Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/996,120	CHAN ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

SEARCHED				
Class	Subclass	Date	Examiner	
568	959	6/16/2006	EW	
205	343	6/16/2006	EW	
205	427	6/16/2006	EW	
205	455	6/16/2006	ÈW	
205	293	6/16/2006	EW	
204	403.1	6/16/2006	EW	
429	218.1	6/16/2006	EW	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor Search	6/16/2006	EW		
EAST	6/16/2006	EW		
Search Updated	12/29/2006	EW		
EAST	12/29/2006	EW		
Search Updated	3/29/2007	EW		
STN	3/29/2007	EW		
Search Updated	6/2/2007	EW		